Interfacial ferromagnetism and atomic structures in high-temperature grown Fe₃O₄/Pt/Fe₃O₄ epitaxial trilayers ⁽³⁾

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T. Kikkawa , M. Suzuki, R. Ramos , M. H. Aguirre , J. Okabayashi, K. Uchida , I. Lucas, A. Anadón, D. Kikuchi, P. A. Algarabel , L. Morellón , M. R. Ibarra, and E. Saitoh

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T. Kikkawa,^{1,2,a)} M. Suzuki,³ R. Ramos,¹ M. H. Aguirre,^{4,5,6,7} J. Okabayashi,⁸ K. Uchida,^{2,9,10} L. Lucas,^{4,5,7} A. Anadón,^{4,5,11} D. Kikuchi,^{1,2} P. A. Algarabel,^{5,12} L. Morellón,^{4,5,7} M. R. Ibarra,^{4,5,6,7} and E. Saitoh^{1,2,10,13,14}

AFFILIATIONS

- WPI Advanced Institute for Materials Research, Tohoku University, Sendai 980-8577, Japan
- ²Institute for Materials Research, Tohoku University, Sendai 980-8577, Japan
- ³Japan Synchrotron Radiation Research Institute (JASRI), Sayo, Hyogo 679-5198, Japan
- ⁴Instituto de Nanociencia de Aragón (INA), Universidad de Zaragoza, E-50018 Zaragoza, Spain
- ⁵Departamento de Física de la Materia Condensada, Universidad de Zaragoza, E-50009 Zaragoza, Spain
- ⁶Laboratorio de Microscopías Avanzadas, Universidad de Zaragoza, E-50018 Zaragoza, Spain
- ⁷Fundación Instituto de Nanociencia de Aragón (FINA), E-50018 Zaragoza, Spain
- Research Center for Spectrochemistry, The University of Tokyo, Bunkyo, Tokyo 113-0033, Japan
- ⁹National Institute for Materials Science, Tsukuba 305-0047, Japan
- ¹⁰Center for Spintronics Research Network, Tohoku University, Sendai 980-8577, Japan
- ¹¹IMDEA Nanociencia, 28049 Madrid, Spain
- 12 Instituto de Ciencia de Materiales de Aragón, Universidad de Zaragoza and Consejo Superior de Investigaciones Científicas, E-50009 Zaragoza, Spain
- ¹³Department of Applied Physics, The University of Tokyo, Tokyo 113-8656, Japan
- 14Advanced Science Research Center, Japan Atomic Energy Agency, Tokai 319-1195, Japan

ABSTRACT

Induced Pt ferromagnetism in Fe₃O₄/Pt/Fe₃O₄ epitaxial trilayer films has been investigated by means of X-ray magnetic circular dichroism (XMCD) at the Pt $L_{3,2}$ -edges at various temperatures from 300 K to 12 K, including the metal-insulator transition temperature of Fe₃O₄ ($T_{\rm V}\sim114\,{\rm K}$). At all the temperatures, we observed clear XMCD signals due to Pt ferromagnetism, the amplitude of which was determined to be 0.39 $\mu_{\rm B}$ at 300 K and 0.52 $\mu_{\rm B}$ at 12 K for the sample with the Pt thickness of \sim 2 nm. Interestingly, these values are comparable to or even greater than those in Pt/3*d*-ferromagnetic-metal (Fe, Ni, Co, and Ni₈₁Fe₁₉) junction systems. The results can be interpreted in terms of a possible Fe interdiffusion into the Pt layer and also possible Fe-Pt alloying due to its high-temperature deposition.

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I. INTRODUCTION

Multilayer systems comprising paramagnetic-metal and magneticoxide layers have widely been used for spin-current generation and detection. Important examples include spin Seebeck effects (SSEs)^{2,3} and spin Hall magnetoresistance (SMR).^{4,5} SSE refers to the generation of a spin current from a heat current in a magnetic material. The spin current is converted into a measurable voltage via the inverse spin Hall effect (ISHE)^{6,7} in an attached metal. SMR refers to the resistance modulation due to the simultaneous action of SHE and ISHE in a metal layer depending on the magnetization orientation in a magnetic layer. Both in SSE and SMR, Pt has often been used as a paramagnetic-metal layer due to its high SHE and ISHE efficiency,

a)Electronic mail: t.kikkawa@imr.tohoku.ac.jp

while various garnet ferrites (e.g., $Y_3Fe_5O_{12}^{2-5,8}$ and $Gd_3Fe_5O_{12}^{9}$) and spinel ferrites (e.g., $NiFe_2O_4$, 8,10 $CoFe_2O_4$, $^{11-13}$ $CoCr_2O_4$, 14 and Fe_3O_4 , $^{8,15-21}$) have been used as a magnetic layer.

In parallel with SMR or SSE, magnetic proximity effects in Pt/magnetic-oxide systems have also been studied extensively. This is because, if the proximity-induced Pt ferromagnetism exists in these systems, the ISHE voltage induced by the spin-current phenomena may be contaminated by the anisotropic magnetoresistance or anomalous Nernst effect due to the magnetized Pt. $^{3,4,8,21-28}$ Hence, the separation of the spin-current contribution from magnetic-proximity-effect contribution is important in spin-tronics, and the detection of Pt ferromagnetism in the Pt/magnetic-oxide systems has attracted much attention. $^{29-38}$ Recent studies demonstrated that, in Pt/Y₃Fe₅O₁₂, Pt/NiFe₂O₄, Pt/CoFe₂O₄, and Pt/Fe₃O₄, the proximity-induced parasitic contribution is negligibly small in comparison with the spin-current contribution to SMR or SSE. $^{4,8,15,17,24-27,29,31-35,39}$

To investigate the proximity-induced ferromagnetism, X-ray magnetic circular dichroism (XMCD)⁴⁰⁻⁴² and X-ray resonant magnetic reflectivity (XRMR)⁴³ techniques have been frequently used. Since the end of the 1990s, a number of XMCD and XRMR studies focusing on Pt/3d-ferromagnetic-metal (Fe, Ni, Co, and Ni₈₁Fe₁₉) junction systems have been reported and the Pt ferromagnetism in these systems has been established. Recently, these techniques were applied for the Pt/magnetic-oxide systems: $Pt/Y_3Fe_5O_{12}$, $^{29-31,36}$ $Pt/NiFe_2O_4$, 32,33,37 $Pt/CoFe_2O_4$, $Pt/MnFe_2O_4$, 37 and Pt/Fe_3O_4 ; 37 in contrast to the Pt/3dferromagnetic-metal systems, the proximity-induced Pt ferromagnetism in these Pt/magnetic-oxide systems was found to be undetectably small when the effect of Pt oxidization is negligible.³⁰ These results suggest that small magnetization of the magnetic oxides is disadvantageous to inducing proximity ferromagnetism in the adjacent Pt layer; Y₃Fe₅O₁₂, NiFe₂O₄, CoFe₂O₄, and Fe₃O₄ are insulators or highly-resistive conductors⁵ their volume magnetization is much smaller than that of the 3d-ferromagnetic-metals.6

In this paper, by means of XMCD at the Pt $L_{3,2}$ -edges, we measured induced Pt ferromagnetism in Fe₃O₄/Pt($t_{Pt} \sim 2$ and 5 nm)/Fe₃O₄ epitaxial trilayer samples at various temperatures ranging from $T = 300 \,\mathrm{K}$ to 12 K, including the metal-insulator transition temperature $T_{\rm V}$ of Fe₃O₄; above (below) $T_{\rm V}\sim 114\,{\rm K},$ Fe₃O₄ is a resistive conductor (insulator). Thermal spin transport in Pt/Fe_3O_4 epitaxial multilayers has been investigated intensively $^{17-21,61}$ since some of the present authors successfully fabricated the high-quality epitaxial films. 17 However, a possible role of the proximity-induced Pt ferromagnetism remains to be clarified.²¹ To investigate the Pt magnetic properties via XMCD, we prepared Fe₃O₄/Pt/Fe₃O₄ epitaxial films, where the Pt layers were sandwiched between Fe₃O₄ films and deposited with hightemperature sputtering to realize the epitaxial growth, as with the previous works. 17-21,61 We observed a remarkably large Pt ferromagnetic moment in the Fe₃O₄/Pt/Fe₃O₄ systems, which is comparable to or even greater than those in the conventional Pt/3dferromagnetic-metal junction systems. The XMCD signal monotonically increases with decreasing temperature from $T = 300 \,\mathrm{K}$ to 12 K, across $T_{\rm V} \sim 114\,{\rm K}$ of Fe₃O₄. The result is distinct from the recent XMCD study in a Pt(2 nm)/Fe₃O₄ film prepared at room

temperature,³⁷ which reports the undetectably small XMCD signals at the temperatures both above and below T_V .

This paper is organized as follows. In Sec. II, we show the sample preparation procedure and the details on the experimental setup for XMCD measurements. In Sec. III A, our samples are characterized in terms of X-ray diffraction (XRD), transmission electron spectroscopy, electrical conductivity, and magnetization. From Secs. III B—III E, we show the systematic experimental results on X-ray absorption spectra (XAS) and XMCD in our samples and also discuss them. Section IV is devoted to summarizing the present study.

II. SAMPLE PREPARATION AND EXPERIMENTAL SETUP

The Fe₃O₄(46 nm)/Pt(~ 2 nm)/Fe₃O₄(54 nm) trilayer sample was grown on MgO (001) substrates by means of pulsed laser deposition (PLD) (for Fe₃O₄) and sputtering (for Pt) at a high temperature of ~480 °C, which allows single-crystalline epitaxial growth. 17,18,62,63 All the growth processes were done *in situ* without breaking vacuum, because our PLD and sputtering systems share the same vacuum chamber. The base pressure was around 1×10^{-9} Torr. For the Fe₃O₄ growth, polycrystalline Fe₃O₄ target was ablated with a KrF excimer laser with 248 nm wavelength and 10 Hz repetition rate. The Fe₃O₄ deposition was done without introducing gas at the substrate temperature of ~480 °C, which results in a chamber pressure of $\sim 1 \times 10^{-6}$ Torr. Without any posttreatments for the Fe₃O₄ and also without changing the temperature, the in situ Pt growth was carried out by DC magnetron sputtering with an Ar pressure of 0.5 mTorr. After forming the Pt layer, the top Fe₃O₄ layer was formed by PLD under the same condition as that for the first Fe₃O₄ layer on the MgO substrate. After the growth of the top Fe₃O₄ layer was completed, the substrate temperature was cooled down to room temperature at the rate of 10 °C/min. We note that in Ref. 63, some of the present authors reported the absence of other Fe phases apart from Fe₃O₄ in the Fe₃O₄ films, fabricated by the same procedure, by means of X-ray photoemission spectroscopy (XPS) on Fe 2p core level in Fe₃O₄ films, where the electronic state only in the near-surface region ($\lesssim 1 \text{ nm}$ from the surface⁶⁴) is detected. To check the effect of Pt thickness on XMCD, we also fabricated a similar Fe₃O₄/Pt/Fe₃O₄ sample with the Pt thickness of $t_{\rm Pt} \sim 5\,{\rm nm}$ under the same condition. Besides, a $Pt(\sim 5 \text{ nm})/Fe_3O_4(40 \text{ nm})/Pt(\sim 2 - 3 \text{ nm})/Fe_3O_4(47 \text{ nm})$ sample was prepared to investigate possible Fe contamination in the (top) Pt film formed on Fe₃O₄ via X-ray absorption spectra (XAS) and XMCD measurements at the Fe $L_{3,2}$ -edges.

The XMCD experiments at the Pt $L_{3(2)}$ -edge $[2p_{3/2(1/2)} \rightarrow 5d$ transition] were performed at the beamline BL39XU of SPring-8 synchrotron radiation facility using the fluorescence detection mode. AXAS were recorded with circularly-polarized X-rays while reversing their helicity at 1 Hz. The circularly-polarized X-rays with a high degree of polarization (\geq 95%) were generated by using a diamond X-ray phase retarder. The Pt $L_{\alpha(\beta)}$ [for the Pt $L_{3(2)}$ -edge] fluorescences were measured with a silicon drift detector. During the XMCD measurements, the Fe₃O₄/Pt($t_{\rm Pt} \sim 2$ and 5 nm)/Fe₃O₄/MgO sample was placed in an electromagnet, where an external magnetic field, H, was applied to the sample at the angle of 5° with respect to the sample surface. Here, the H direction was parallel or antiparallel

to the direction of the angular momentum vector of the incident X-ray beam. The measurements of element-specific magnetization (ESM) curves were also carried out at the constant energy of $E=11\,569\,\mathrm{eV}$ (the XMCD peak position for the Pt L_3 -edge) in the range of $|H|\leq 20\,\mathrm{kOe}$ at $T=300\,\mathrm{K}$ and $|H|\leq 12\,\mathrm{kOe}$ at $T=12\,\mathrm{K}$.

III. RESULTS AND DISCUSSION

A. Sample characterization

1. X-ray diffraction

Figure 1 shows the X-ray diffraction (XRD) patterns of the $Fe_3O_4/Pt(\sim 2 \text{ nm})/Fe_3O_4//MgO$ sample around the (002) Bragg peak from the MgO substrate. We observed the (004) reflection from the Fe₃O₄ layers as well as the (002) reflection from the Pt layer, which confirms the out-of-plane orientation of $Fe_3O_4[001]/Pt[001]/Fe_3O_4[001]//MgO[001]$. As shown in the inset to Fig. 1, the (004) reflection of Fe₃O₄ consists of two peaks with slightly different peak angles, 43.20° and 43.30°, marked with blue and red triangles, respectively. This result is due to the different underlayers for each Fe₃O₄ layer; the peak at the lower (higher) angle can be attributed to the diffraction from the Fe₃O₄ layer grown on the MgO substrate (grown on the Pt film), since the peak position at the lower one is in agreement with that of the (004) reflection from a Fe₃O₄ film grown on a MgO (001) substrate.¹⁷ From the positions of the diffraction peaks, the out-of-plane lattice constants for the Fe₃O₄ layers grown on the MgO substrate and grown on the Pt film were, respectively, determined to be 8.370 Å and 8.352 Å. The Laue oscillations of the (004) reflection were observed for both the Fe₃O₄ layers, indicating high crystalline coherence of each Fe₃O₄ layer.

2. Transmission electron microscopy

To further investigate the structural quality of the $Fe_3O_4/Pt(\sim 2 \text{ nm})/Fe_3O_4$ sample, we performed transmission

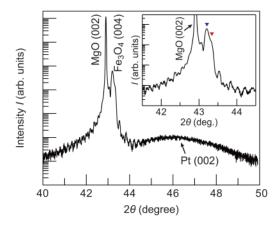


FIG. 1. $2\theta-\omega$ diffraction patterns of the Fe₃O₄/Pt(\sim 2 nm)/Fe₃O₄ trilayer sample grown on the MgO (001) substrate. The inset shows the magnified view in the range of 41.50° < 2θ < 44.50°, where the Fe₃O₄ (004) diffraction peaks at lower and higher angles are marked by the blue and red triangles, respectively.

electron microscopy (TEM) and high-angle annular dark-field scanning TEM (HAADF-STEM) (see Fig. 2). The images of the overall sample cross section [Figs. 2(a) and 2(c)] show that each layer has a smooth surface and mostly uniform thickness. We confirmed that the bottom (first) Fe $_3$ O $_4$ layer is epitaxially grown on the MgO (001) substrate and its interface is sharp [see Fig. 2(d) and its clear contrast change at the Fe $_3$ O $_4$ /MgO interface]. The Pt layer formed on the first Fe $_3$ O $_4$ layer also shows epitaxial growth with the [001] orientation [see Figs. 2(g) and 2(h)]. Subsequently, the top (second) Fe $_3$ O $_4$ layer is also found to grow epitaxially on the Pt (001) layer with keeping high crystallization. These results ensure full epitaxial growth from the substrate to the top Fe $_3$ O $_4$ layer, consistent with the XRD result.

From the high resolution (HR) HAADF-STEM images shown in Figs. 2(g) and 2(h), we notice that there exists intermediate brightness regions and soft undulation between the Pt and Fe₃O₄ interface, indicating that the Pt film may be discontinuous and/or that the Pt/Fe₃O₄ interface may not be atomically sharp. In fact, the HR-TEM image in Fig. 2(b) captures a discontinuous region of Pt, and also the STEM images in Figs. 2(c) and 2(f) indicate that the Pt film consists of clusterlike structures due to the granular-type growth of Pt. To clarify the origin of the intermediate brightness regions and soft undulation at the Pt/Fe₃O₄ interface in more detail, we fabricated a Fe₃O₄/Pt(10 nm)/Fe₃O₄ sample; owing to the Pt film much thicker than the previous sample, we can examine the interfacial property without considering the effect of discontinuity of the Pt film. Figure 3(a) shows the HR-TEM bright field image of the interface between the 10-nm-thick Pt and Fe₃O₄ formed on a MgO substrate. We found that in the vicinity of the Pt/Fe₃O₄ interface, there are small lobules (nanograins) (< 1 nm) consisting of Fe₃O₄ and Pt that are alternately formed with each other along the lateral direction [see Fig. 3(a)]. Figure 3(b) shows a corresponding HR-HAADF-STEM image of the same sample. The alternate Fe₃O₄ and Pt lobules observed by HR-TEM [Fig. 3(a)] were found to appear as intermediate brightness and soft undulation in the region around 1.5-2 unit cells of the Pt film from the interface. To evaluate the interfacial Fe, O, and Pt elements profile, we carried out electron energy loss spectroscopy (EELS) and energy dispersive X-ray spectroscopy (EDX).²¹ As shown in Fig. 3(c), around the interface, the element profile varies in the range of 0.75-1 nm and there are finite Fe and O contributions in the Pt layer. This can be due to the overlap of the interfacial Fe₃O₄ and Pt lobules [Fig. 3(a)] existing along the depth direction (i.e., perpendicular to the cross plane) or simply due to some Pt, Fe, and O diffusion. Unfortunately, we cannot separate these two possible contributions in the present analysis.

3. Electric and magnetic properties of Fe₃O₄

We also characterized the electric and magnetic properties of the Fe₃O₄ film by four-probe conductivity measurements and vibrating sample magnetometry, respectively. We found that the electrical conductivity σ of our Fe₃O₄ film is $\sim\!1.4\times10^2/\Omega$ cm, being consistent with the literature value, 65 which confirms the metallic behavior of the Fe₃O₄ film at room temperature. As shown in Fig. 4(a), as the temperature T decreases, σ was found to monotonically decrease. Moreover, below $\sim\!110\,\text{K},\,\sigma$ dramatically

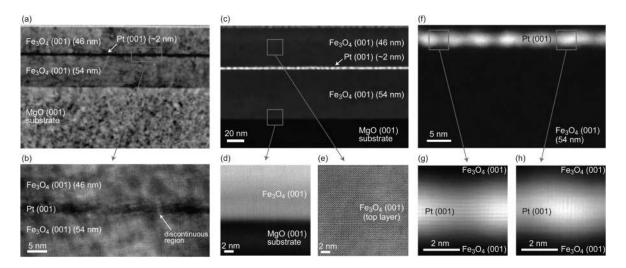


FIG. 2. (a) and (b) Cross-sectional TEM images of the $Fe_3O_4/Pt(\sim 2 \text{ nm})/Fe_3O_4/MgO$ sample for (a) the overall sample cross section and for (b) the $Fe_3O_4/Pt/Fe_3O_4$ interfaces with higher resolution. (c)–(h) HAADF-STEM images of the $Fe_3O_4/Pt/Fe_3O_4/Pt/Fe_3O_4/MgO$ sample for (c) the overall sample cross section, for (d) the Fe_3O_4/MgO interface, for (e) the top Fe_3O_4 layer grown on the Pt layer, and for (f) the $Fe_3O_4/Pt/Fe_3O_4$ interfaces. The HR-HAADF-STEM images focusing on the vicinity of the $Fe_3O_4/Pt/Fe_3O_4$ interfaces are shown in (g) and (h). The TEM lamellae specimen was prepared using a focused ion beam. HAADF-STEM was carried out with a probe-aberration-corrected FEI Titan 60-300 operated at 300 kV.

decreases with decreasing T, showing the metal-insulator (Verwey) transition of Fe₃O₄. Figure 4(b) shows the observed magnetic field H dependence of the magnetization M (M-H curve) for the Fe₃O₄/Pt(\sim 2 nm)/Fe₃O₄ sample at T=300 K. The saturation M value was found to be 333 emu/cm³, smaller than the bulk value of

 $480 \,\mathrm{emu/cm^3},^{60}$ which can be attributed to the higher density of antiphase boundaries of PLD-grown Fe₃O₄ films. From M-T curves, the Verwey transition temperature (T_{V}) of our Fe₃O₄ films was determined to be $\sim 114 \,\mathrm{K}$ [see the inset in Fig. 4(b)], consistent with the literature values for Fe₃O₄ films with similar thickness. Signature of the control of the

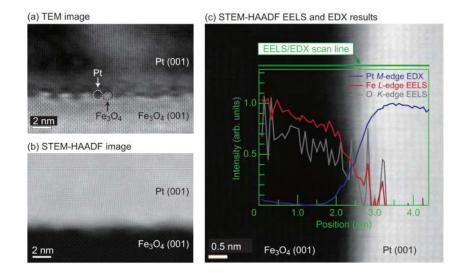


FIG. 3. (a) HR-TEM and (b) HR-HAADF-STEM images around the Pt/Fe $_3$ O $_4$ interface of the Fe $_3$ O $_4$ /Pt(10 nm)/Fe $_3$ O $_4$ //MgO sample. In (a), the observed small Fe $_3$ O $_4$ and Pt lobules (nanograins) are marked by dashed circles. (c) EDX line scan for Pt (*M*-edge, blue solid line) and EELS line scans for Fe (*L*-edge, red solid line) and O (*K*-edge, gray solid line) across the interface indicated by the green solid line. The EELS measurement was done by using a probe-corrected Titan G2, where the beam diameter is around 0.1 - 0.15 nm, ensuring enough resolution to probe the elements at the interface. Besides, by diffraction analysis, the incident electron beam was directed to be orthogonal to the film cross plane. This ensures that the observed signal comes from the parallel plane and does not come from crosswise planes that may result in an artificial composition-mixed signal.

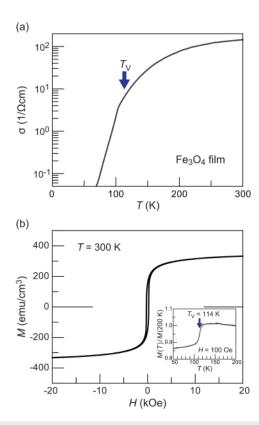


FIG. 4. (a) T dependence of the electrical conductivity σ for a 40-nm-thick Fe₃O₄ (001) film grown on a MgO (001) substrate. (b) M-H curve of the Fe₃O₄/Pt(\sim 2 nm)/Fe₃O₄ sample at T=300 K, measured with a vibrating sample magnetometer. The inset to (b) shows the normalized M-T curve measured at H=100 Oe. The external field of 100 Oe is smaller than the coercive field of Fe₃O₄ ($H_c\sim250$ Oe). The T_V value can be determined via this measurement, since, with decreasing T, the M value at $H<H_c$ steeply decreases when the Verwey transition occurs at $T=T_V$ due to the enhancement of H_c (magnetic anisotropy). ^{65,66}

B. XAS, XMCD, and ESM results at T = 300 K

Now, we present the results on the X-ray absorption of the ${\rm Fe_3O_4/Pt}(\sim 2\,{\rm nm})/{\rm Fe_3O_4}$ sample at $T=300\,{\rm K}$ and $H=20\,{\rm kOe}$. Figure 5(a) shows the measured XAS for the Pt $L_{3,2}$ -edges with right (μ_+) and left (μ_-) circularly-polarized X-rays, where the XAS edge jump is normalized to 1 (2.22⁻¹) for the L_3 -edge $(L_2$ -edge). The whiteline intensity, the ratio of the absorption maximum at the L_3 -edge to the edge jump, of $(\mu_+ + \mu_-)/2$ is estimated to be ~ 1.25 , comparable to that for a Pt foil. 31,68 Oscillation behaviors were observed in the extended X-ray absorption fine structure (EXAFS) region. These are characteristics of metallic Pt, 31 ensuring the quality of our Pt film.

The XAS shown in Fig. 5(a) exhibits a clear helicity dependence. Figure 5(b) shows the corresponding XMCD spectra $(\mu_+ - \mu_-)$ at T = 300 K and H = 20 kOe. The sign of the XMCD signal is negative at the L_3 -edge (11 569 eV) and positive at the L_2 -edge (13 280 eV), consistent with Pt films having magnetic

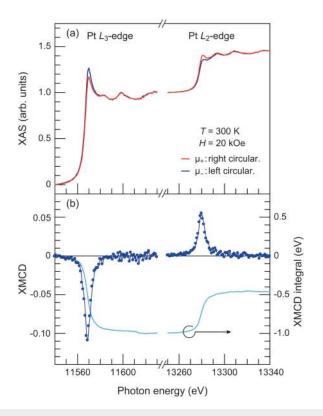


FIG. 5. (a) The normalized XAS for the Pt $L_{3,2}$ -edges of the Fe $_3$ O $_4$ /Pt(\sim 2 nm)/Fe $_3$ O $_4$ sample at T=300 K and H=20 kOe. The XAS edge jump, defined as the difference in the XAS intensity between 11 540 eV (13 250 eV) and 11 630 eV (13 340 eV), is normalized to 1 (2.22 $^{-1}$) for the L_3 -edge (L_2 -edge) according to Refs. 67 and 68. The XAS offset value for the L_3 -edge (L_2 -edge) is set to be 0 (1). 29,31,51,69 μ_+ (μ_-) represents the XAS obtained with the right (left) circularly-polarized X-rays. (b) The XMCD spectra (blue circles with solid lines) and their integral (light-blue solid lines) for the Pt $L_{3,2}$ -edges of the Fe $_3$ O $_4$ /Pt/Fe $_3$ O $_4$ sample.

moments parallel to $H^{.48,51}$ Significantly, the XMCD intensity of ~ 0.11 (0.055) at the L_3 -edge (L_2 -edge) with respect to the XAS edge jump is two orders of magnitude greater than that for a Pt foil, ⁶⁸ in which only the Pauli paramagnetism of Pt appears. This result suggests that our Pt film sandwiched between the Fe₃O₄ films acquires considerable induced magnetic moments, a situation different from the previous reports in conventional Pt/magnetic-oxide systems $^{29,31-35}$ including the Pt(2 nm)/Fe₃O₄ system reported in Ref. 37.

To check the H dependence of the induced moments in Pt, we measured the ESM curve at the Pt L_3 -edge. We found that the XMCD magnitude increases with increasing H from zero and saturates at $H \sim 5$ kOe and that the sign of the XMCD signal changes by reversing the H direction (see Fig. 6). The ESM curve is well consistent with the ferromagnetic M-H curve for the Fe $_3$ O $_4$ layers (see the inset to Fig. 6), suggesting that the observed XMCD signal is due to the Pt ferromagnetism whose magnetization process is governed by the Fe $_3$ O $_4$ layers.

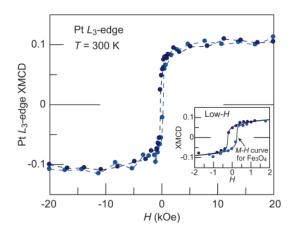


FIG. 6. The ESM curve at the Pt L_3 -edge of the Fe $_3$ O $_4$ /Pt(\sim 2 nm)/Fe $_3$ O $_4$ sample at T=300 K and the fixed photon energy of 11 569 eV. The inset shows the comparison between the ESM curve (dark-blue and blue circles) and the M-H curve for the Fe $_3$ O $_4$ layers (black solid lines, in arbitrary units) in the range of |H|<2 kOe.

The observed XMCD intensity, or the induced magnetic moment, in the present Fe₃O₄/Pt/Fe₃O₄ sample is quite large. The Pt ferromagnetic moment value at $H=20\,\mathrm{kOe}$ was estimated to be $m_{\mathrm{tot}}=m_{\mathrm{orb}}+m_{\mathrm{spin}}=0.39\pm0.05\mu_{\mathrm{B}}$ by XMCD

sum-rule analysis, $^{48,69,70}_{}$ where $m_{
m orb}=0.05\pm0.01\,\mu_{
m B}$ and $m_{
m spin} = 0.34 \pm 0.05 \, \mu_{
m B}$ are the orbital and (effective) spin magnetic moments, respectively (see Sec. A in the supplementary material for details on the sum-rule analysis). The ratio of the orbital-to-spin magnetic moment is $m_{\rm orb}/m_{\rm spin}=0.15\pm0.02$. Interestingly, the m_{tot} value is comparable to or greater than those in Pt/3d-ferromagnetic-metal (Fe, Ni, Co, and Ni₈₁Fe₁₉) junction and $L1_0$ -FePt alloy systems (see Table I). For example, the m_{tot} values in the Pt(2 and 1 nm)/Co bilayers were, respectively, reported to be $0.16\mu_{\rm B}$ and $0.28\mu_{\rm B}$, which are smaller than that in our Fe₃O₄/Pt(\sim 2 nm)/Fe₃O₄ trilayer system. Also, the m_{tot} value in the Pt(1 nm)/Ni₈₁Fe₁₉ superlattice (SL) system, where the Pt film is sandwiched by ferromagnetic Ni₈₁Fe₁₉ layers in a similar way as our sample system, was estimated to be $0.27 \mu_{\rm B}$, ⁵³ again giving a value smaller than the present one. In contrast, the $m_{\rm orb}/m_{\rm spin}$ ratio is almost the same as those in the previous Pt/3*d*-ferromagnetic-metal junctions (see Table I).

C. Temperature dependence of XMCD

We carried out systematic measurements on the T dependence of the XMCD using the same $Fe_3O_4/Pt(\sim 2 \text{ nm})/Fe_3O_4$ sample. Figure 7(a) shows the Pt L_3 -edge XMCD spectra at H=12 kOe at several T values (left vertical axis) and their integrals (right vertical axis) and Fig. 7(b) shows the XMCD-integral values as a function of T. We found that the XMCD amplitude monotonically increases with decreasing T [see Fig. 7(a)]. The XMCD-integral value at the

TABLE I. Comparison of induced Pt magnetic moments at room temperature in various junction systems comprising Pt and magnetic materials and also $L1_0$ -FePt alloys. 71 M_{FM} represents the volume magnetization value of the ferro(ferri)magnetic (FM) layers. The M_{FM} value for $L1_0$ -FePt alloys is obtained by calculating the Fe contribution to the volume magnetization of $L1_0$ -FePt.

System	Method	$m_{ m tot} \ (\mu_{ m B}/{ m Pt})$	$m_{ m spin} \ (\mu_{ m B}/{ m Pt})$	$m_{ m orb} \ (\mu_{ m B}/{ m Pt})$	$m_{ m orb}/m_{ m spin}$	M _{FM} (emu/cm ³)	Comment on Pt fabrication
$Fe_3O_4/Pt(\sim 2 \text{ nm})/Fe_3O_4$	XMCD	0.39	0.34	0.050	0.15	333	High-T growth
$Fe_3O_4/Pt(\sim 5 \text{ nm})/Fe_3O_4$	XMCD	0.36	0.32	0.043	0.14	333	High-T growth
Pt(2 nm)/Co ⁴⁸	XMCD	0.16	0.14	0.020	0.14	1440^{60}	
Pt(1 nm)/Co ⁴⁸	XMCD	0.28	0.24	0.037	0.15	1440^{60}	
Pt/Fe interface ³²	XRMR	0.6				1710 ⁶⁰	
Pt/Ni ₈₁ Fe ₁₉ interface ⁵²	XRMR	0.22				830 ⁶⁰	
Pt/Ni interface ⁵²	XRMR	0.08				488 ⁶⁰	
$Pt(1 nm)/Ni_{81}Fe_{19} SL^{53}$	XMCD	0.27			0.18	830 ⁶⁰	
L ₁₀ -FePt alloy ⁵⁵	XMCD	0.38	0.30	0.075	0.25	840 ⁵⁵	
$L1_0$ -FePt alloy ⁵⁶	XMCD	0.32	0.28	0.039	0.14	840 ⁵⁶	
$Pt(1.5 \text{ nm})/Y_3Fe_5O_{12}^{30}$	XMCD	0.054	0.044	0.010	0.23	140^{30}	
$Pt(3 nm)/Y_3Fe_5O_{12}^{29}$	XMCD	< 0.003				110 ²⁹	
$Pt(2 nm)/Fe_3O_4^{37}$	XMCD	< 0.005				$\sim 500^{37}$	Room-T growth
$Pt(7 nm)/CoFe_2O_4^{35}$	XMCD	< 0.002				160^{35}	-
$Pt(2 nm)/CoFe_2O_4^{37}$	XMCD	< 0.005				$\sim 200^{37}$	Room-T growth
$Pt(4 nm)/CoFe_2O_4^{38}$	XMCD	< 0.01				$\sim 340^{38}$	Room-T growth
$Pt(4 nm)/CoFe_2O_4^{38}$	XMCD	0.24				$\sim 340^{38}$	High-T growth
$Pt(2 nm)/MnFe_2O_4^{37}$	XMCD	< 0.005				$\sim 100^{37}$	Room-T growth
$Pt(2 nm)/NiFe_2O_4^{37}$	XMCD	< 0.005				$\sim 70^{37}$	Room-T growth
Pt/NiFe ₂ O ₄ interface ³²	XRMR	< 0.02				$\sim 230^{32}$	-
Pt/NiFe ₂ O ₄ interface ³³	XRMR	< 0.04				244 ³³	

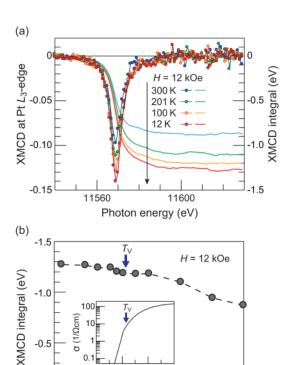


FIG. 7. (a) The XMCD spectra for the Pt L_3 -edge of the Fe $_3$ O $_4$ /Pt(\sim 2 nm)/Fe $_3$ O $_4$ sample (left vertical axis) and their integral (right vertical axis) measured at H=12 kOe at several T values. (b) T dependence of the XMCD integral at H=12 kOe. The inset to (b) shows the T dependence of σ of the Fe $_3$ O $_4$ film, which is the same as that shown in Fig. 4(a).

200 300

T(K)

200

300

T(K)

100

0

lowest temperature (12 K) increases by a factor of \sim 1.4 compared to that at 300 K. Interestingly, this enhancement is more prominent than that of magnetization of Fe₃O₄ (\sim 1.05 in the same T range⁷²). Furthermore, the metal-insulator transition of Fe₃O₄ does not affect the present Pt ferromagnetism, since no meaningful change of the XMCD signal was observed at around $T_{\rm V} \sim$ 114 K [see Fig. 7(b)].

Figure 8 shows the ESM curve at the Pt L_3 -edge at 12 K (dark-red and red circles) and the comparison of the ESM curve with that at 300 K (dark-blue and blue circles). We found that the amplitude of the ESM curve at 12 K is greater than that at 300 K, consistent with the XMCD spectra shown in Fig. 7(a). We also found that the coercivity of the ESM curve enhances at 12 K compared to that at 300 K, in agreement with that of the M-H curve of the Fe₃O₄ layers (see the inset of Fig. 8), which is due to the increase of the magnetic anisotropy of Fe₃O₄ below $T_{\rm V}$.

From the integrated XAS and XMCD measured at $T=12\,\mathrm{K}$ and $H=12\,\mathrm{kOe}$, the Pt ferromagnetic moment value under this condition was estimated to be $m_{\mathrm{tot}}=m_{\mathrm{orb}}+m_{\mathrm{spin}}=0.52\pm0.06\,\mu_{\mathrm{B}},$

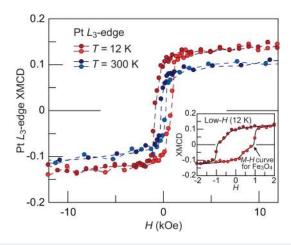


FIG. 8. The ESM curve at the Pt L_3 -edge of the Fe $_3$ O $_4$ /Pt(\sim 2 nm)/Fe $_3$ O $_4$ sample at $T=12\,\rm K$ (dark-red and red circles with dashed lines). For comparison, the ESM curve measured at $T=300\,\rm K$ is also plotted (dark-blue and blue circles with dashed lines). The inset shows the comparison between the ESM curve at $T=12\,\rm K$ (dark-red and red circles) and M-H curve for the Fe $_3$ O $_4$ layers at $T=10\,\rm K$ (black solid lines, in arbitrary units) in the range of $|H|<2\,\rm kOe$.

where $m_{\rm orb}=0.06\pm0.01\,\mu_{\rm B}$ and $m_{\rm spin}=0.46\pm0.06\,\mu_{\rm B}$ (see Sec. B in the supplementary material for details, in which the XAS and XMCD full spectra for the Pt $L_{3,2}$ -edges at 12 K and 12 kOe are shown). As expected from the XMCD data shown in Fig. 7(b), the $m_{\rm tot}$ value at 12 K increases by a factor of \sim 1.4 compared to that at 300 K. On the other hand, the ratio of the orbital-to-spin magnetic moment is $m_{\rm orb}/m_{\rm spin}=0.13\pm0.01$, which agrees with that estimated at 300 K within the experimental error. The $m_{\rm tot}$ value at 12 K is more than two times greater than that in Pt/Ni junction systems at similar temperatures $^{44-46}$ and is comparable to (or even slightly greater than) that of $L1_0$ -FePt alloys (= $0.45\pm0.03\,\mu_{\rm B}/{\rm Pt}$ at $15\,{\rm K}^{54}$).

D. Effect of Pt thickness on XMCD

To reveal the effect of Pt thickness t_{Pt} on the XMCD amplitude, we also measured XMCD using a Fe $_3O_4/Pt(\sim 5\,\text{nm})/Fe_3O_4$ sample at $T = 300 \,\mathrm{K}$ and 12 K, where the 2-nm-thick Pt film is replaced with the thicker one ($t_{\rm Pt}\sim 5\,{\rm nm}$). As shown in Fig. 9(a), clear XMCD signals were observed, whose intensity at 12 K is larger than that at 300 K, consistent with the $t_{\rm Pt} \sim 2\,{\rm nm}$ sample. From the integrated XAS and XMCD measured at $T = 300 \,\mathrm{K}$, the Pt ferromagnetic moment value of the present $t_{\rm Pt} \sim 5 \, \rm nm$ sample was estimated to be $m_{\rm tot} = m_{\rm orb} + m_{\rm spin} = 0.36 \pm 0.04 \mu_{\rm B}$, where $m_{\rm orb} = 0.043 \pm 0.007 \,\mu_{\rm B}$ and $m_{\rm spin} = 0.32 \pm 0.04 \,\mu_{\rm B}$. These values are comparable to those for the $t_{\rm Pt}\sim 2\,{\rm nm}$ sample at $T=300\,{\rm K}$ within the experimental error (see also Table I). The Pt thickness dependence result is distinct from the previous XMCD study at the Pt $L_{3,2}$ -edges of $Pt(t_{Pt})/Co$ samples, 48 where the substantial decrease of the XMCD signal with increasing t_{Pt} is observed. In Ref. 48, this feature is explained by the model that the

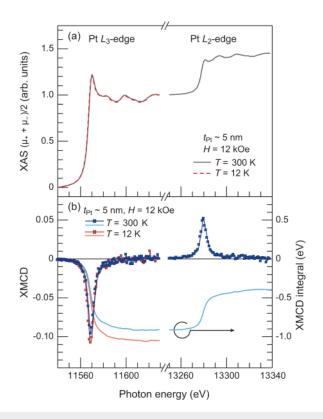


FIG. 9. (a) The normalized XAS $[(\mu_+ + \mu_-)/2]$ for the Pt $L_{3,2}$ -edges of the Fe₃O₄/Pt(\sim 5 nm)/Fe₃O₄ sample at $T=300\,\mathrm{K}$ and $H=12\,\mathrm{kOe}$ (gray solid lines). (b) The XMCD spectra (blue circles with solid lines) and the corresponding XMCD integrals (light-blue solid lines) at $T=300\,\mathrm{K}$ and $H=12\,\mathrm{kOe}$ for the Pt $L_{3,2}$ -edges of the Fe₃O₄/Pt(\sim 5 nm)/Fe₃O₄ sample. In (a) and (b), the normalized XAS and the XMCD spectrum/integral for the Pt L_3 -edge of the Fe₃O₄/Pt(\sim 5 nm)/Fe₃O₄ sample measured at $T=12\,\mathrm{K}$ are also plotted, respectively.

ferromagnetic Pt moment exponentially decreases with the distance from the interface, the decay length of which is estimated to be 0.41 nm.

E. Discussion on the large Pt ferromagnetic moment in $Fe_3O_4/Pt/Fe_3O_4$

The giant Pt ferromagnetic moment $m_{\rm tot}$ value in the present Fe₃O₄/Pt/Fe₃O₄ systems is unconventional in the light of the volume magnetization ($M_{\rm FM}$) value of the Fe₃O₄ layers. In the previous reports for the Pt/3d-ferromagnetic-metal junction systems at room temperature, the proximity-induced $m_{\rm tot}$ values tend to scale with the $M_{\rm FM}$ values of the ferromagnetic layers (see Table I for 300 K). In fact, the $m_{\rm tot}$ vs $M_{\rm FM}$ scaling was recently confirmed for Pt/Ni_{1-x}Fe_x and Pt/Co_{1-x}Fe_x bilayers via XRMR measurements in Ref. 73. However, our XMCD result clearly deviates from this tendency; although the $M_{\rm FM}$ value of the Fe₃O₄ layer is much smaller than those of the 3d-ferromagnetic-metal layers as shown in Table I, the $m_{\rm tot}$ value in our systems is comparable to or greater

than those in the Pt/3*d*-ferromagnetic-metal systems. Such deviation may become more outstanding at the lowest temperature (12 K); the $m_{\rm tot}$ value in the present Fe₃O₄/Pt(\sim 2 nm)/Fe₃O₄ system increases by a factor of \sim 1.4 compared to that at 300 K, while the magnetization of Fe₃O₄ increases only by \sim 1.05 in the same T range, as mentioned in Sec. III C.

Our results are distinct also from the recent XMCD results in the Pt(2 nm)/Fe₃O₄ film reported by Collet *et al.* in Ref. 37, in which the XMCD signal was undetectably small at the temperatures above and below $T_{\rm V}$ (290 and 10 K). Here, their Pt film was formed with room-temperature sputtering, while our Pt films were fabricated with high-temperature sputtering (\sim 480 °C). This difference in the fabrication process may affect the resultant XMCD signal.

Very recently, Vasili et al. 38 reported systematic XMCD results in Pt(4 nm)/CoFe₂O₄ films, where the Pt deposition temperature was varied. They observed a large XMCD signal in a Pt/CoFe₂O₄ sample when the Pt film is formed at a high temperature of 400 °C, whose Pt ferromagnetic moment value was determined to be $m_{\rm tot} = 0.24 \,\mu_{\rm B}$. This is in contrast to the absence of the XMCD signal in the other Pt/CoFe₂O₄ sample, where the Pt film is formed at room temperature.³⁸ Through systematic XAS and XMCD measurements at the Fe and Co $L_{3,2}$ -edges in both the total electron yield (TEY) and fluorescence yield (FY) modes and also STEM-EELS observations, they found that, in the high-T grown Pt/CoFe₂O₄ sample, the XAS and XMCD spectra for the (surfacesensitive) TEY mode contain metallic Fe and Co signals and also found that the Pt/CoFe₂O₄ interface becomes less sharper than that deposited at room T. From these results, they concluded that, in the high-T grown Pt/CoFe₂O₄ sample, there are an interfacial Pt-(Co, Fe) alloying and/or a (Co, Fe)-interdiffusion into the Pt layer, which are negligible for the room-T grown one.³⁸ The feature results in the large (negligibly small) XMCD for the high-T (room-T) grown sample.

Based on the above arguments, the large XMCD signal and large Pt ferromagnetic moment observed in the present Fe₃O₄/Pt/Fe₃O₄ systems prepared at a high temperature can be interpreted in terms of the possible heat-induced Fe interdiffusion into the Pt layer and Pt-Fe alloying (cannot be explained by the conventional interfacial magnetic proximity-induced Pt ferromagnetism). This scenario is also supported by our experimental facts, as shown below. (1) The Pt/Fe₃O₄ interfaces are not atomically sharp and the interdiffusion is likely to be present (Sec. III A 2). (2) The Pt ferromagnetic moment m_{tot} increases more strongly than the T dependence of M of Fe₃O₄ (i.e., the present m_{tot} does not correlate with the M intensity of Fe₃O₄, different from the previous reports) (Secs. III C and III E). (3) The m_{tot} value remains almost unchanged (decreases by only 10%) by increasing the Pt thickness from 2 to 5 nm, which does not agree with the proximity-induced Pt ferromagnetism scenario and is indeed different from the previous Pt thickness dependent XMCD results in Pt/Co bilayers, where the Pt films are deposited at room temperature⁴⁸ (Sec. III D). Furthermore, we confirmed that the XAS and XMCD results in the TEY mode for the Fe L_{3,2}-edges of our $Pt(\sim 5 \text{ nm})/Fe_3O_4/Pt(\sim 2-3 \text{ nm})/Fe_3O_4$ reasonably agree with the results in the high-T grown Pt/CoFe₂O₄ reported by Vasili et al., 38 indicating the presence of metallic Fe states in our Pt layer (see Sec. C in the supplementary material for details). The result

also supports our present scenario on the origin of the large induced Pt ferromagnetism in the Fe $_3$ O $_4$ /Pt/Fe $_3$ O $_4$ systems. Nevertheless, further work would be needed to obtain a complete physical picture of the present large Pt ferromagnetism.

IV. CONCLUSION

To summarize, by means of XMCD, we have investigated the induced Pt ferromagnetism in Fe₃O₄/Pt($t_{Pt} \sim 2$ and 5 nm)/Fe₃O₄ epitaxial trilayer films at various temperatures, covering the metalinsulator transition temperature of Fe₃O₄ ($T_{\rm V} \sim 114$ K). The result shows the appearance of the large induced Pt ferromagnetic moment $m_{\rm tot}$ of $0.39\,\mu_{\rm B}$ ($0.36\,\mu_{\rm B}$) at $300\,{\rm K}$ and $0.52\,\mu_{\rm B}$ at $12\,{\rm K}$ for the $t_{\rm Pt} = 2 \, \rm nm$ (5 nm) sample. The value does not follow the conventional scaling on $m_{\rm tot}$ vs volume magnetization $M_{\rm FM}$ of the magnetic layers. The appearance of the large XMCD (Pt ferromagnetism) in the present Fe₃O₄/Pt/Fe₃O₄ systems prepared at a high temperature of 480 °C is different from the absence of the measurable XMCD in Pt/Fe₃O₄ in the recent report in Ref. 37, where the Pt film is formed at room temperature. Our results can be interpreted in terms of the possible heat-induced Fe interdiffusion into the Pt layer and Fe-Pt alloying due to its high-temperature deposition.

Recently, some of the present authors found measurable anomalous Nernst signals in Fe₃O₄/Pt/Fe₃O₄ epitaxial trilayers in a wide temperature range even below $T_{\rm V}$ of Fe₃O₄. The result is attributed to the magnetized Pt due to the possible Fe interdiffusion into the Pt layer by the high-temperature Pt deposition, in a similar way to the present study. We anticipate that our comprehensive temperature, magnetic field, and Pt thickness dependent XMCD results provide useful information to elucidate the origin of their observation. 21

SUPPLEMENTARY MATERIAL

See the supplementary material for the details of XMCD sum-rule analysis and XAS and XMCD full spectra for the Pt $L_{3,2}$ -edges of Fe₃O₄/Pt(\sim 2 nm)/Fe₃O₄ at $T=12\,\mathrm{K}$ and for the Fe $L_{3,2}$ -edges of Pt(\sim 5 nm)/Fe₃O₄/Pt(\sim 2 – 3 nm)/Fe₃O₄ sample at room temperature.

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